



# P3M06300K3 SiC MOS N-Channel Enhancement Mode

$V_{RRM}$	=	650 V
$I_D$	=	9 A
$I_D(100^\circ\text{C})$	=	7 A
$R_{DS(on)}$	=	300 m $\Omega$

## SiC MOS P3M06300K3 N-Channel Enhancement Mode



### Features

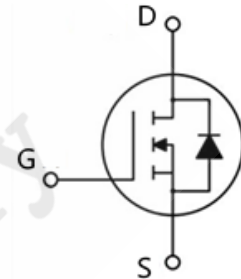
- High Blocking Voltage with Low On-Resistance
- High-Frequency Operation
- Ultra-Small  $Q_{gd}$
- 100% UIS tested

### Standards Benefits

- Improve System Efficiency
- Increase Power Density
- Reduce Heat Sink Requirements
- Reduction of System Cost

### Applications

- Solar Inverters
- Active Clamp Flyback, LLC resonant, Class D
- Mobile fast-chargers, adapters
- Notebook adaptors
- High Voltage DC/DC Converters
- Switch Mode Power Supplies



TO-247-3

Gate	1
Drain	2
Source	3



### Order Information

Part number	Package	Marking
P3M06300K3	TO-247-3	P3M06300K3



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## 1. Maximum Ratings

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise

Parameter	Symbol	Value	Unit	Test Conditions
Drain - Source Voltage	$V_{DSmax}$	650	V	$V_{GS} = -3\text{V}$ $I_D = 100\mu\text{A}$
Gate - Source Voltage (dynamic)	$V_{GSmax}$	-8 / +20	V	AC ( $f > 1\text{ Hz}$ )
Gate - Source Voltage (static)	$V_{GSop}$	-3 / +15	V	Static
Continuous Drain Current	$I_D$	9	A	$V_{GS} = 15\text{V}$ $T_C = 25^\circ\text{C}$
		7		$V_{GS} = 15\text{V}$ $T_C = 100^\circ\text{C}$
Power Dissipation	$P_D$	38	W	
Operating Junction	$T_J$	-55 To +175	$^\circ\text{C}$	
Storage Temperature	$T_{stg}$	-55 To +175	$^\circ\text{C}$	
Solder Temperature	$T_L$	260	$^\circ\text{C}$	
Mounting Torque	$M_d$	1 8.8	Nm lbf-in	M3 or 6-32 screw



## 2. Electrical Characteristics

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise

Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	650	/	/	V	$V_{GS} = -3V$ $I_D = 100\mu A$
Gate Threshold Voltage	$V_{GS(th)}$	1.8	2.2	/	V	$V_{DS} = V_{GS}$ $I_D = 5mA$ $T_J = 25^\circ\text{C}$
		/	1.45	/	V	$V_{DS} = V_{GS}$ $I_D = 5mA$ $T_J = 175^\circ\text{C}$
Reverse Bias Drain Current	$I_{DSS}$	/	0.5	10	$\mu A$	$V_{GS} = -3V$ $V_{DS} = 650V$
Gate-Source Leakage Current	$I_{GSS}$	/	20	250	nA	$V_{GS} = 15V$ $V_{DS} = 0V$
Drain-Source On-State Resistance	$R_{DS(on)}$	/	300	500	m $\Omega$	$V_{GS} = 15V$ $I_D = 4.5A$
Trans conductance	$g_{fs}$	/	2.7	/	S	$V_{DS} = 20V$ $I_{DS} = 4.5A$ $T_J = 25^\circ\text{C}$
		/	2.3	/	S	$V_{DS} = 20V$ $I_{DS} = 4.5A$ $T_J = 175^\circ\text{C}$
Input Capacitance	$C_{iss}$	/	338	/	pF	$V_{GS} = 0V$ $V_{DS} = 400V$ $f = 1MHz$ $V_{AC} = 25mV$
Output Capacitance	$C_{oss}$	/	39.4	/	pF	
Reverse Transfer Capacitance	$C_{rss}$	/	3.35	/	pF	
Coss Stored Energy	$E_{oss}$	/	5.6	/	$\mu J$	



Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Gate to Source Charge	$Q_{gs}$	/	2.45	/	nC	$V_{DS} = 400V$ $I_{DS} = 4.5A$ $V_{GS} = -3 \text{ to } 15V$ $I_G = 4mA$
Gate to Drain Charge	$Q_{gd}$	/	2.75	/		
Total Gate Charge	$Q_g$	/	9.04	/		

### 3. Reverse Diode Characteristics

At  $T_J = 25^\circ C$ , unless specified otherwise

Parameter	Symbol	Value		Unit	Test Conditions
		Typ.	Max.		
Diode Forward Voltage	$V_{SD}$	4.5	/	V	$V_{GS} = -3V$ $I_{SD} = 2.75A$ $T_J = 25^\circ C$
		4	/	V	$V_{GS} = -3V$ $I_{SD} = 2.75A$ $T_J = 175^\circ C$
Continuous Diode Forward Current	$I_S$	7	/	A	$V_{GS} = -3V$

### 4. Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction to Case	$R_{\theta JC}$	3.93	$^\circ C/W$

## 5. Typical Performance

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise

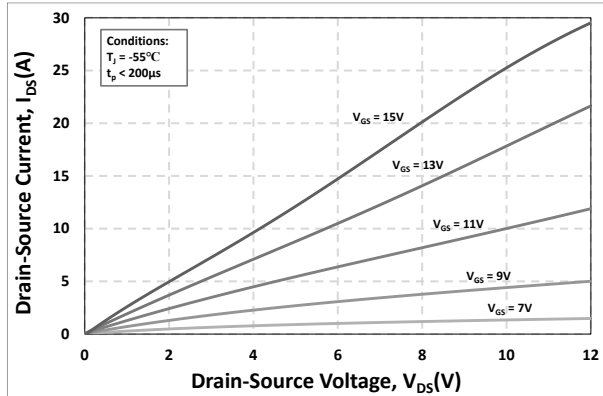


Figure 1. Output Characteristics  $T_J = -55^\circ\text{C}$

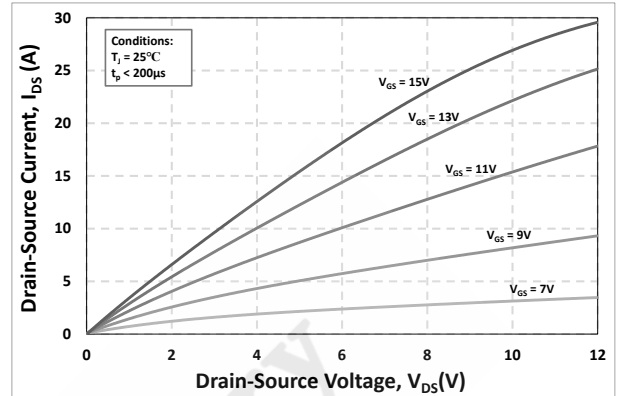


Figure 2. Output Characteristics  $T_J = 25^\circ\text{C}$

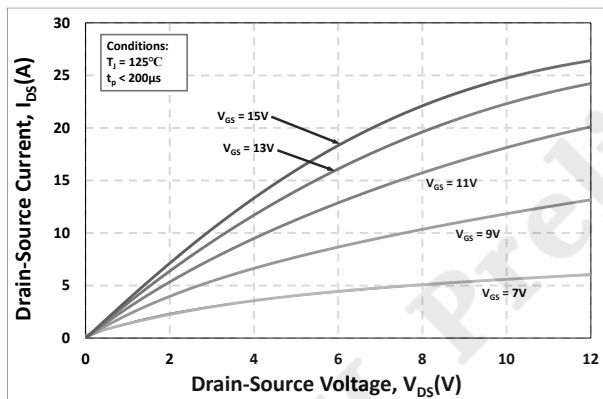


Figure 3. Output Characteristics  $T_J = 125^\circ\text{C}$

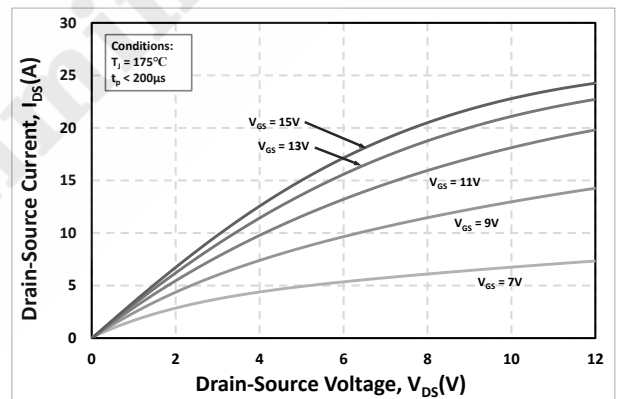


Figure 4. Output Characteristics  $T_J = 175^\circ\text{C}$

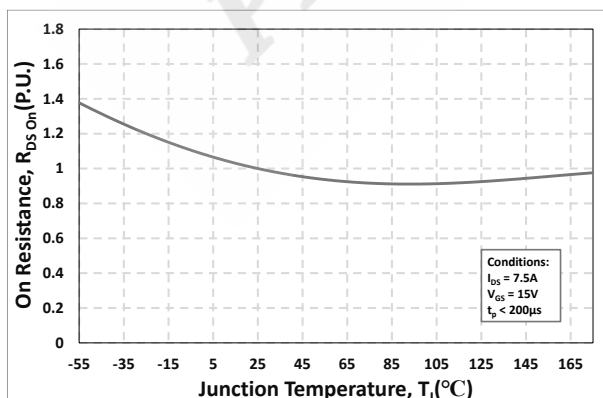


Figure 5. Normalized On-Resistance vs. Temperature

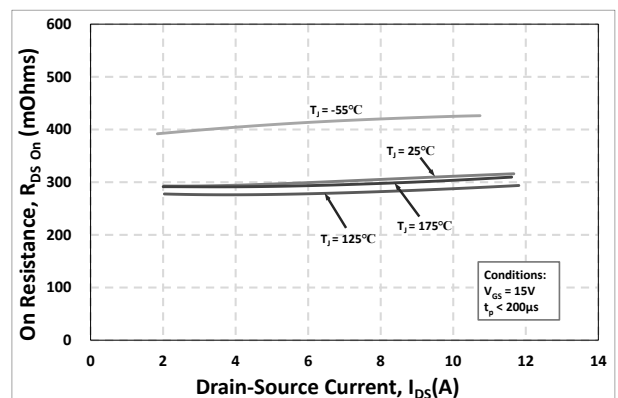


Figure 6. On-Resistance vs. Drain Current Various Temperatures

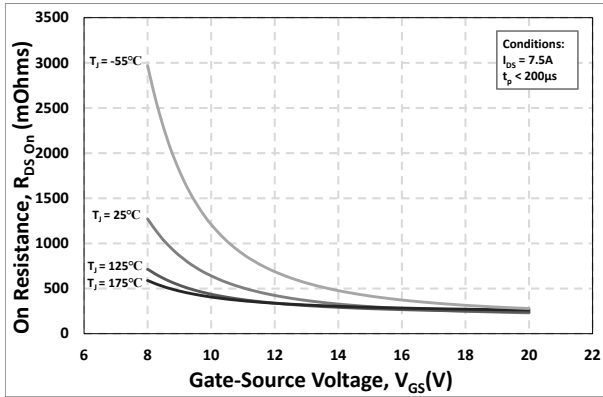


Figure 7. On-Resistance vs. Gate-Source Voltage

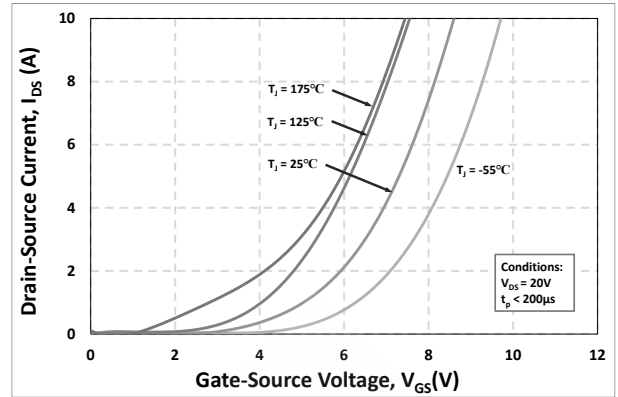


Figure 8. Transfer Characteristic for Various Junction Temperatures

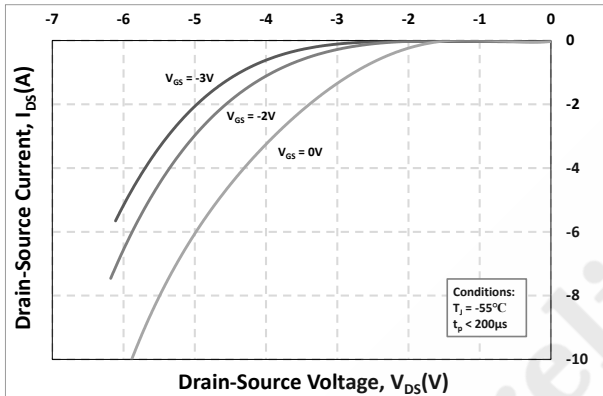


Figure 9. Body Diode Characteristic at -55°C

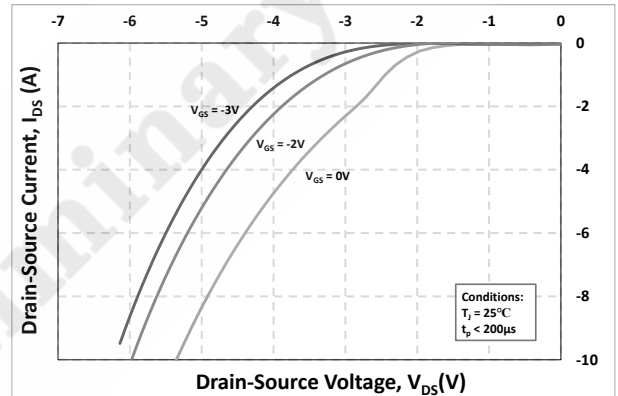


Figure 10. Body Diode Characteristic at 25°C

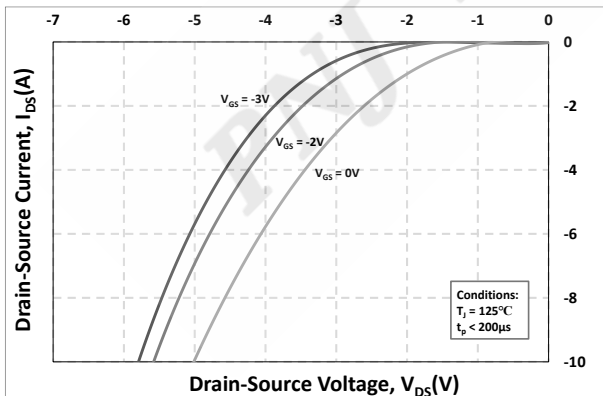


Figure 11. Body Diode Characteristic at 125°C

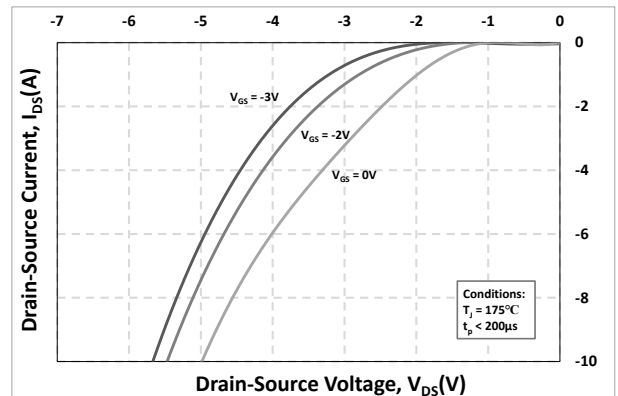


Figure 12. Body Diode Characteristic at 175°C



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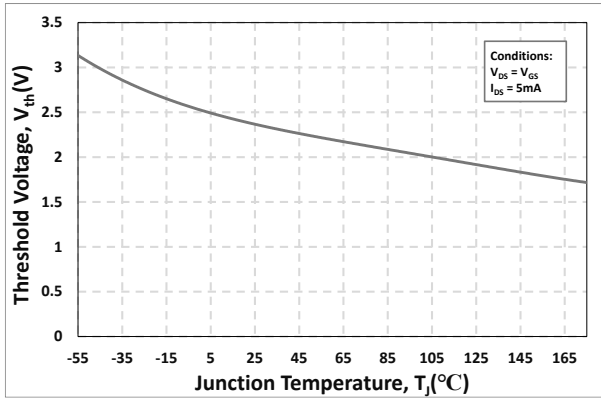


Figure 13. Threshold Voltage vs. Temperature

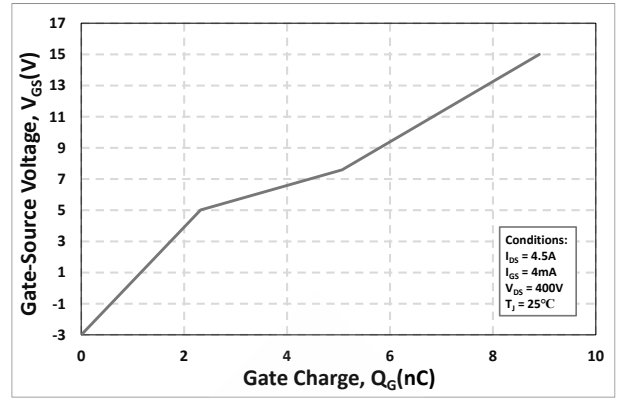


Figure 14. Gate Charge Characteristics

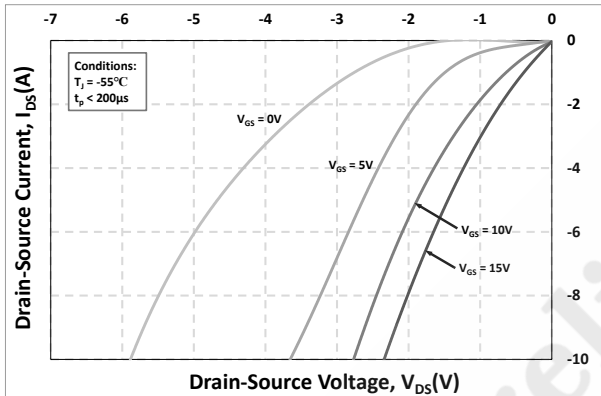


Figure 15. 3rd Quadrant Characteristic at -55°C

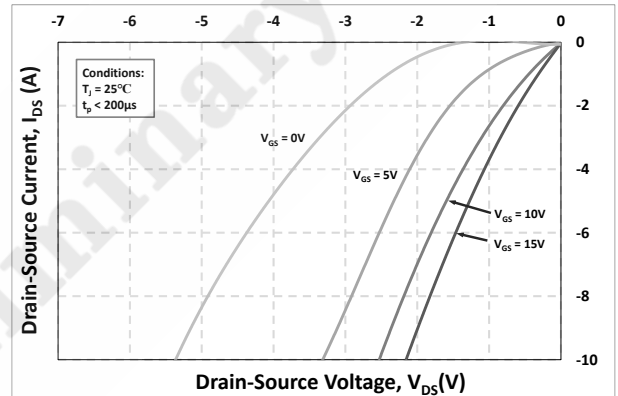


Figure 16. 3rd Quadrant Characteristic at 25°C

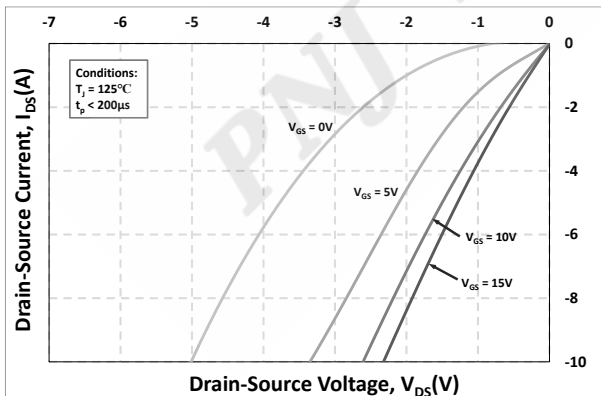


Figure 17. 3rd Quadrant Characteristic at 125°C

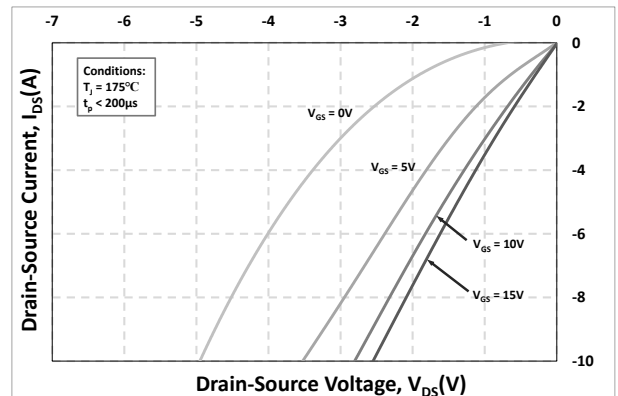


Figure 18. 3rd Quadrant Characteristic at 175°C





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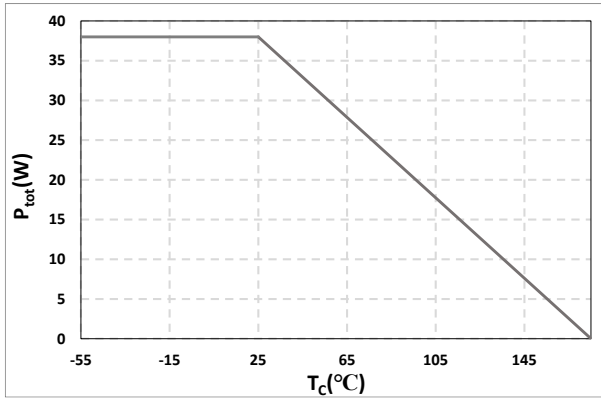


Figure 19. Maximum Power Dissipation Derating vs. Case Temperature

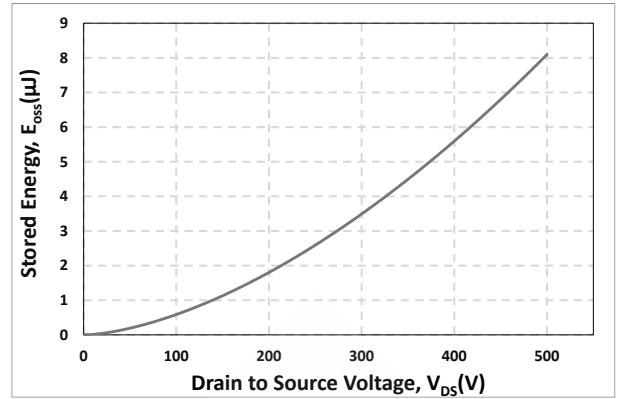


Figure 20. Output Capacitor Stored Energy

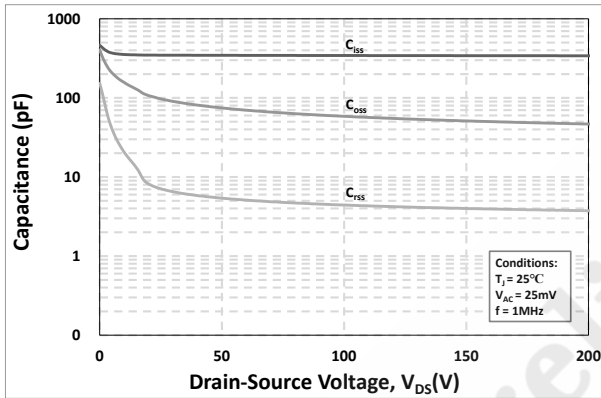


Figure 21. Capacitances vs. Drain-Source Voltage (0 - 200V)

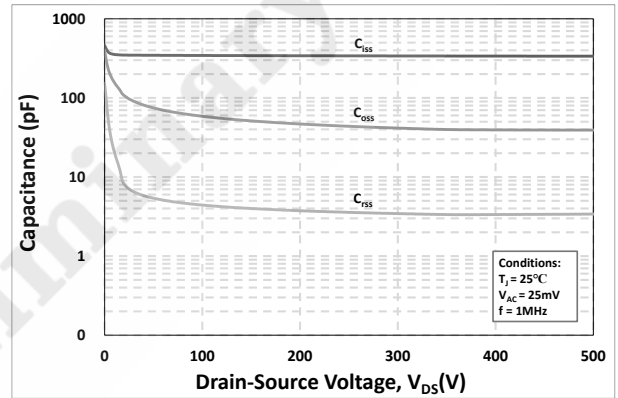
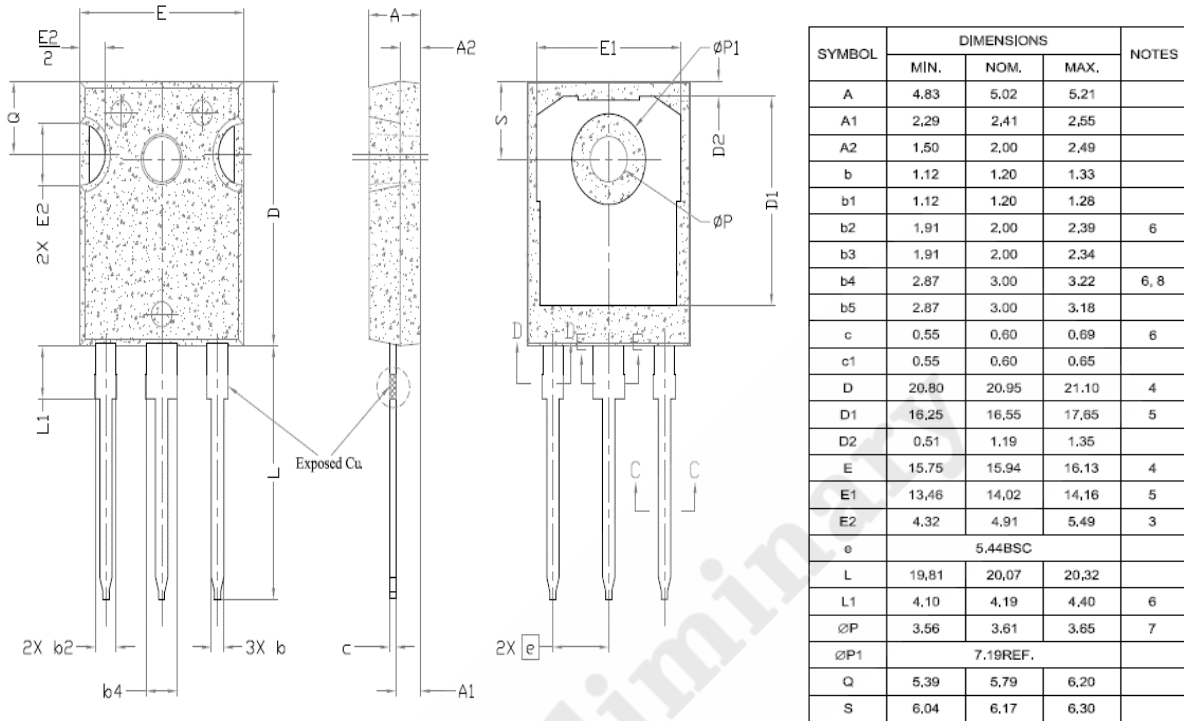


Figure 22. Capacitances vs. Drain-Source Voltage (0 - 500V)

## 6. Package Outlines



Drawing and Dimensions

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